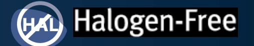
# EPC2206 – Automotive 80 V (D-S) Enhancement Mode Power Transistor

$V_{DS}$ , 80 V
$R_{DS(on)}$ , 2.2 mΩ
$I_D$ , 90 A
AEC-Q101




Revised December 11, 2023

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low $Q_G$ and zero $Q_{RR}$. The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

**Application Notes:**
- Easy-to-use and reliable gate, Gate Drive ON = 5–5.25 V typical, OFF = 0 V (negative voltage not needed)
- Top of FET is electrically connected to source

**Questions:** Ask a GaN Expert

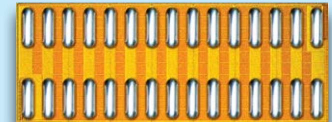
| Maximum Ratings | | | |
|---|---|---|---|
| | PARAMETER | VALUE | UNIT |
| $V_{DS}$ | Drain-to-Source Voltage (Continuous) | 80 | V |
| $I_D$ | Continuous ($T_A$ = 25°C) | 90 | A |
| | Pulsed (25°C, $T_{PULSE}$ = 300 µs) | 390 | |
| $V_{GS}$ | Gate-to-Source Voltage | 6 | V |
| | Gate-to-Source Voltage | -4 | |
| $T_J$ | Operating Temperature | -40 to 150 | °C |
| $T_{STG}$ | Storage Temperature | -40 to 150 | |

| Thermal Characteristics | | | |
|---|---|---|---|
| | PARAMETER | TYP | UNIT |
| $R_{θJC}$ | Thermal Resistance, Junction-to-Case | 0.4 | °C/W |
| $R_{θJB}$ | Thermal Resistance, Junction-to-Board | 1.1 | |
| $R_{θJA}$ | Thermal Resistance, Junction-to-Ambient (Note 1) | 42 | |

Note 1: $R_{θJA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See https://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.

| Static Characteristics ($T_J$ = 25°C unless otherwise stated) | | | | | | |
|---|---|---|---|---|---|---|
| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
| $BV_{DSS}$ | Drain-to-Source Voltage | $V_{GS}$ = 0 V, $I_D$ = 500 µA | 80 | | | V |
| $I_{DSS}$ | Drain-Source Leakage | $V_{GS}$ = 0 V, $V_{DS}$ = 80 V | | 20 | 200 | µA |
| $I_{GSS}$ | Gate-to-Source Forward Leakage | $V_{GS}$ = 6 V, $T_J$ = 25°C | | 0.02 | 4 | mA |
| | Gate-to-Source Forward Leakage# | $V_{GS}$ = 6 V, $T_J$ = 125°C | | 0.1 | 9 | mA |
| | Gate-to-Source Reverse Leakage | $V_{GS}$ = -4 V | | 20 | 200 | µA |
| $V_{GS(TH)}$ | Gate Threshold Voltage | $V_{DS}$ = $V_{GS}$, $I_D$ = 13 mA | 0.7 | 1.2 | 2.5 | V |
| $R_{DS(on)}$ | Drain-Source On Resistance | $V_{GS}$ = 5 V, $I_D$ = 29 A | | 1.8 | 2.2 | mΩ |
| $V_{SD}$ | Source-Drain Forward Voltage# | $I_S$ = 0.5 A, $V_{GS}$ = 0 V | | 1.5 | | V |

# Defined by design. Not subject to production test.



Die Size: 6.05 x 2.3 mm

EPC2206 eGaN® FETs are supplied only in passivated die form with solder bars.

**Applications**
- 48 V automotive power
- Open rack server architectures
- High power density DC-DC converters
- Isolated power supplies
- Class-D audio
- Low inductance motor drive

**Benefits**
- Ultra high efficiency
- No reverse recovery
- Ultra low $Q_G$
- Small footprint

Scan QR code or click link below for more information including reliability reports, device models, demo boards!

https://l.ead.me/EPC2206

| Dynamic Characteristics# ($T_J$ = 25°C unless otherwise stated) | | | | | | | |
|---|---|---|---|---|---|---|---|
| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
| $C_{ISS}$ | Input Capacitance | $V_{DS}$ = 40 V, $V_{GS}$ = 0 V | | 1610 | 1940 | pF |
| $C_{RSS}$ | Reverse Transfer Capacitance | | | 15 | | |
| $C_{OSS}$ | Output Capacitance | | | 1100 | 1650 | |
| $C_{OSS(ER)}$ | Effective Output Capacitance, Energy Related (Note 2) | $V_{DS}$ = 0 to 40 V, $V_{GS}$ = 0 V | | 1450 | | |
| $C_{OSS(TR)}$ | Effective Output Capacitance, Time Related (Note 3) | | | 1790 | | |
| $R_G$ | Gate Resistance | | | 0.3 | | Ω |
| $Q_G$ | Total Gate Charge | $V_{DS}$ = 40 V, $V_{GS}$ = 5 V, $I_D$ = 29 A | | 15 | 19 | nC |
| $Q_{GS}$ | Gate-to-Source Charge | $V_{DS}$ = 40 V, $I_D$ = 29 A | | 4.1 | | |
| $Q_{GD}$ | Gate-to-Drain Charge | | | 3 | | |
| $Q_{G(TH)}$ | Gate Charge at Threshold | | | 2.7 | | |
| $Q_{OSS}$ | Output Charge | $V_{DS}$ = 40 V, $V_{GS}$ = 0 V | | 72 | 108 | |
| $Q_{RR}$ | Source-Drain Recovery Charge | | | 0 | | |

# Defined by design. Not subject to production test.
All measurements were done with substrate connected to source.
Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as $C_{OSS}$ while $V_{DS}$ is rising from 0 to 50% $BV_{DSS}$.
Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as $C_{OSS}$ while $V_{DS}$ is rising from 0 to 50% $BV_{DSS}$.

**Figure 1: Typical Output Characteristics at 25°C**

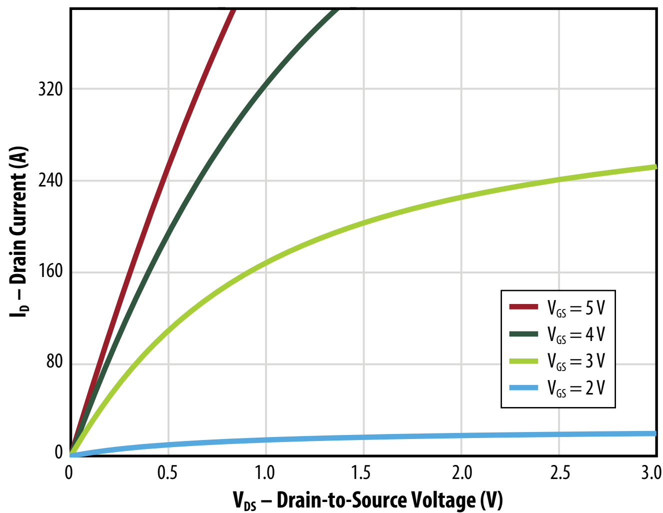



**Figure 2: Typical Transfer Characteristics**

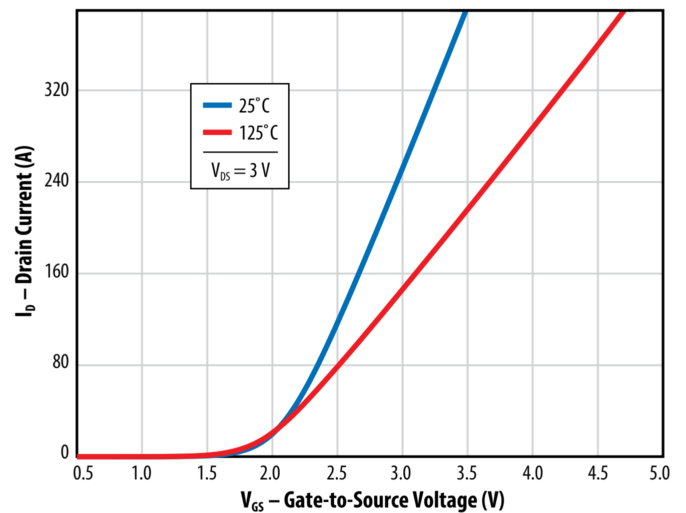



**Figure 3: Typical $R_{DS(on)}$ vs. $V_{GS}$ for Various Drain Currents**

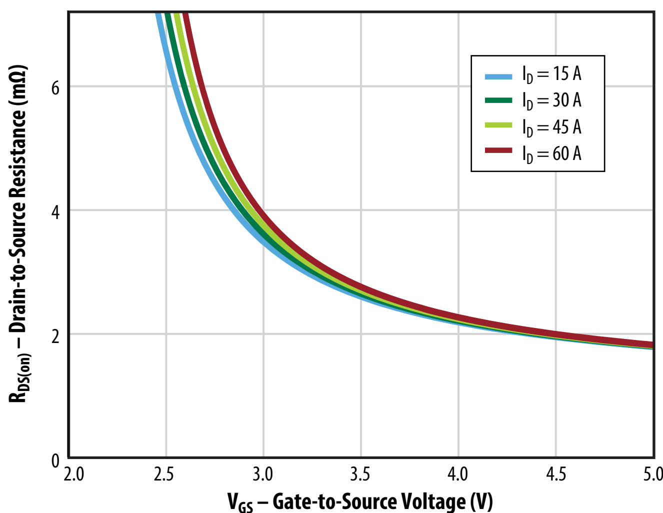



**Figure 4: Typical $R_{DS(on)}$ vs. $V_{GS}$ for Various Temperatures**

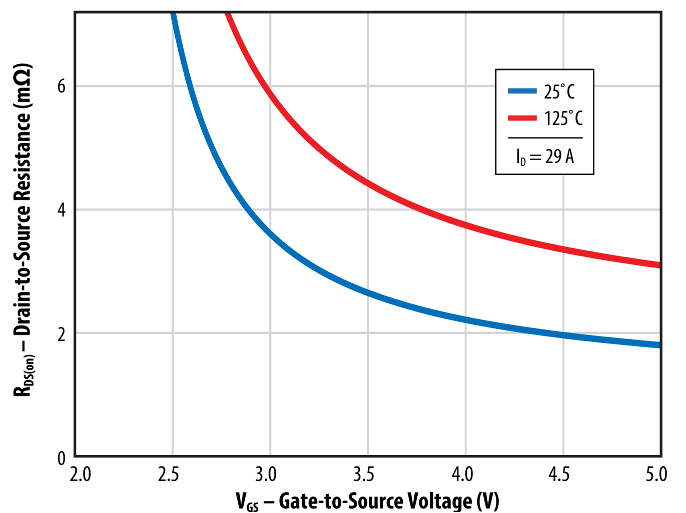


**Figure 5a: Typical Capacitance (Linear Scale)**

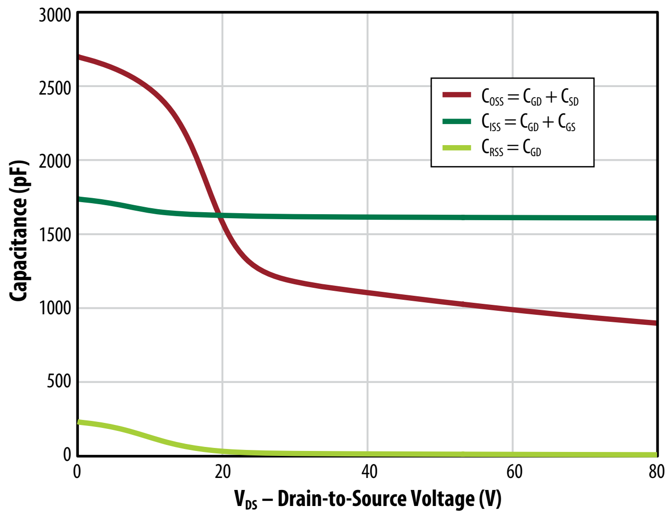



**Figure 5b: Typical Capacitance (Log Scale)**

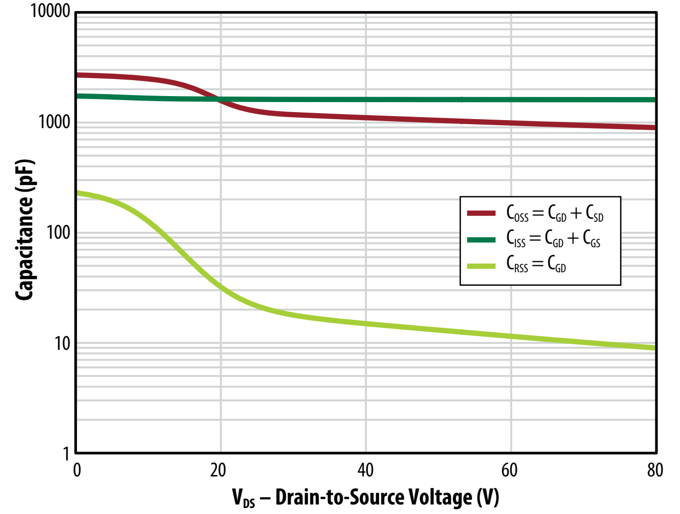



**Figure 6: Typical Output Charge and $C_{OSS}$ Stored Energy**

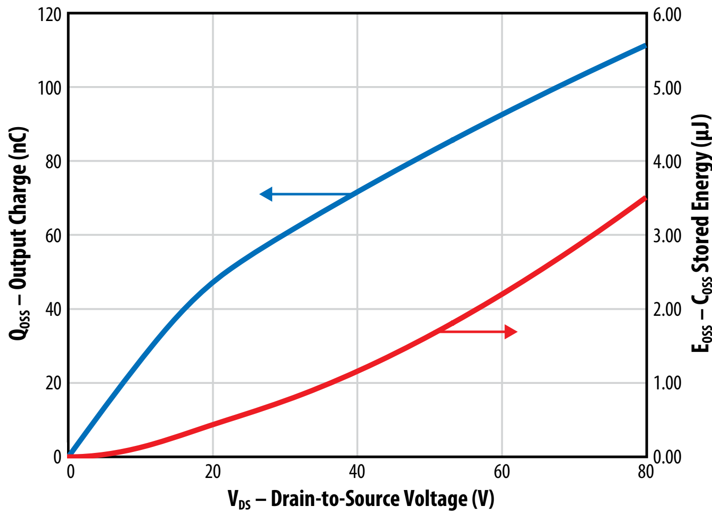



**Figure 7: Typical Gate Charge**

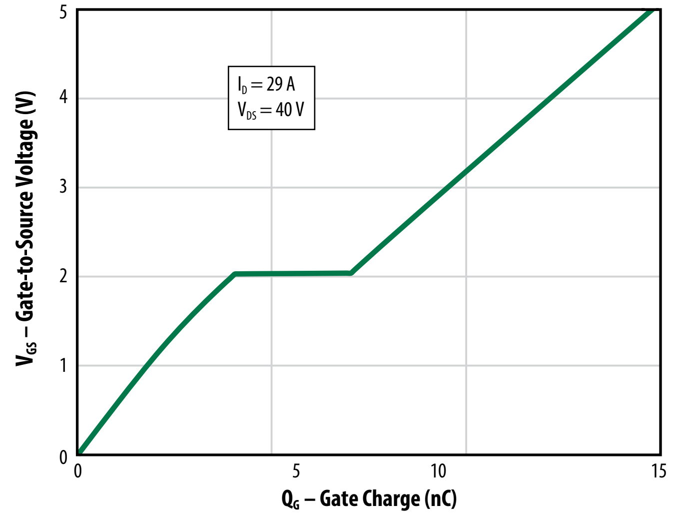
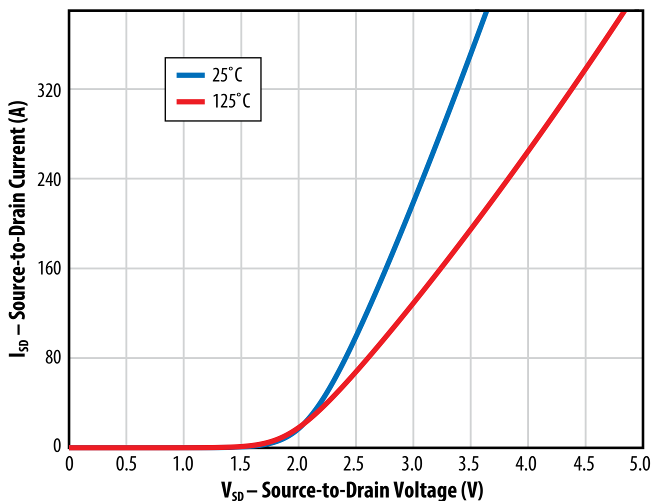
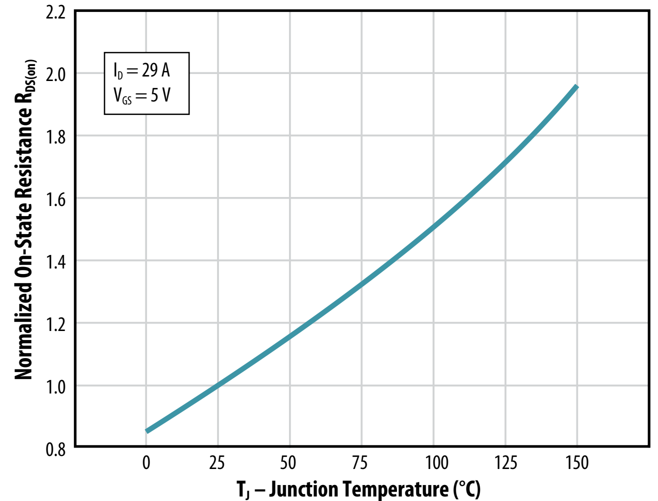


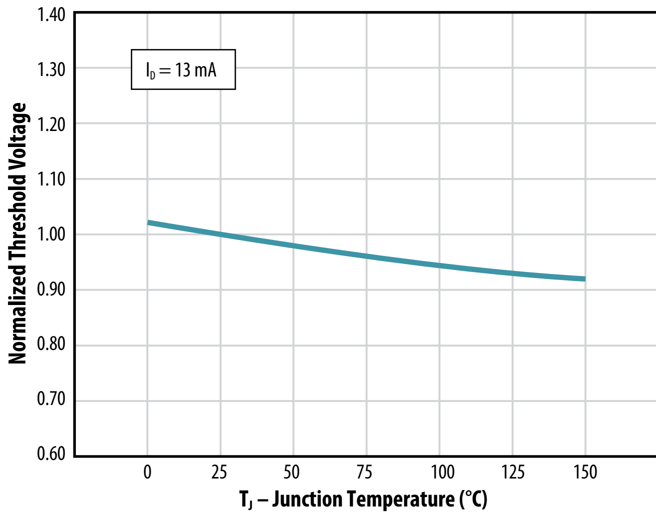

**Figure 8: Typical Reverse Drain-Source Characteristics**

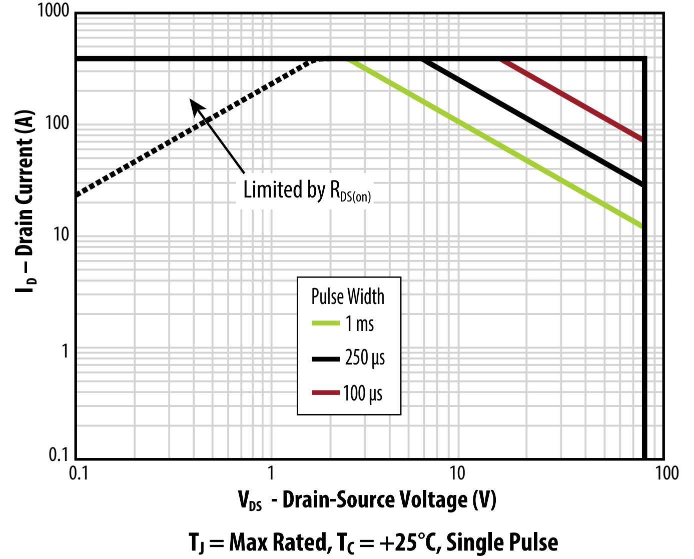



Note: Negative gate drive voltage increases the reverse drain-source voltage.
EPC recommends 0 V for OFF.

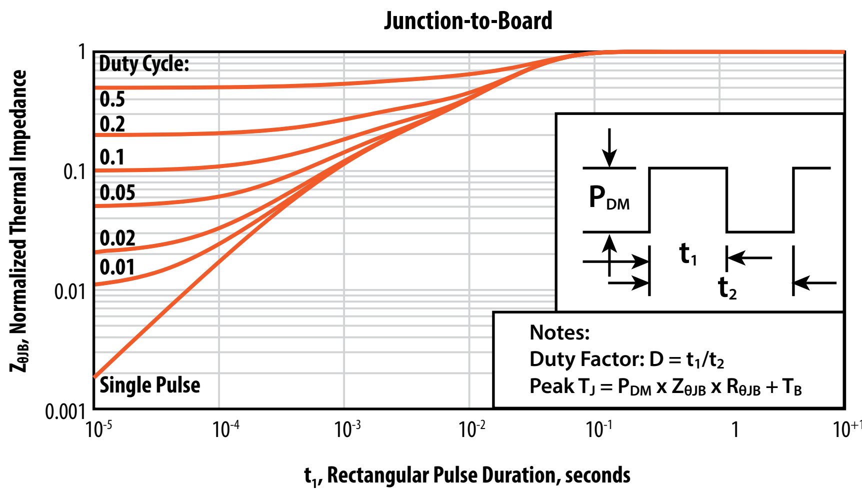
**Figure 9: Typical Normalized On-State Resistance vs. Temp.**

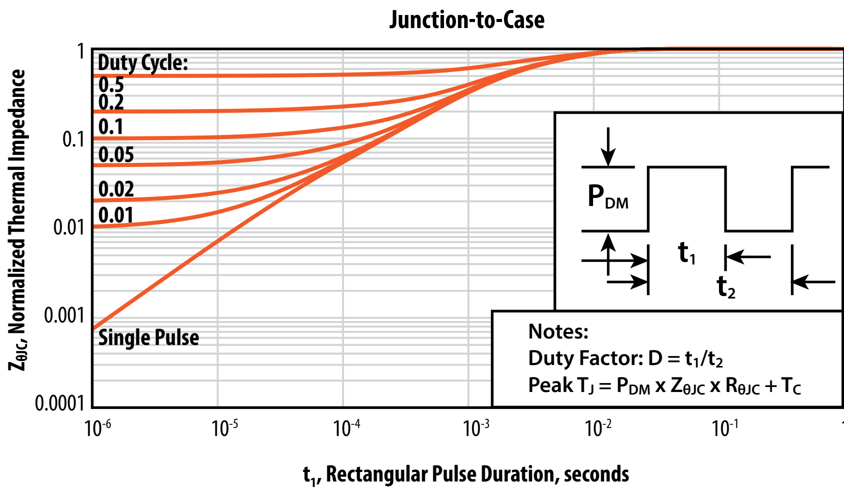




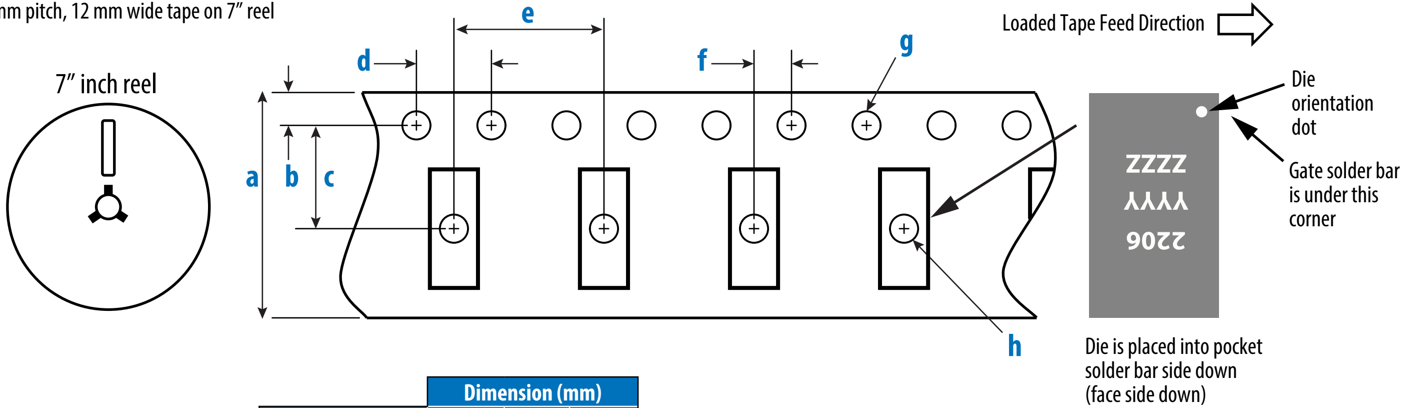

## Figure 12: Typical Transient Thermal Response Curves



## TAPE AND REEL CONFIGURATION

8 mm pitch, 12 mm wide tape on 7" reel

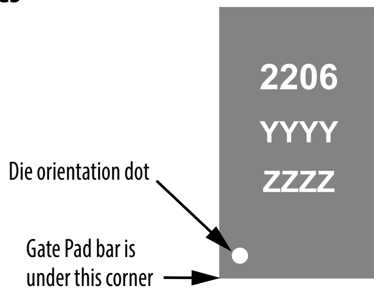



| EPC2206 (Note 1) | Dimension (mm) Target | MIN | MAX |
|---|---|---|---|
| a | 12.00 | 11.90 | 12.30 |
| b | 1.75 | 1.65 | 1.85 |
| c (Note 2) | 5.50 | 5.45 | 5.55 |
| d | 4.00 | 3.90 | 4.10 |
| e | 8.00 | 7.90 | 8.10 |
| f (Note 2) | 2.00 | 1.95 | 2.05 |
| g | 1.50 | 1.50 | 1.60 |
| h | 1.50 | 1.50 | 1.75 |

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.

Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

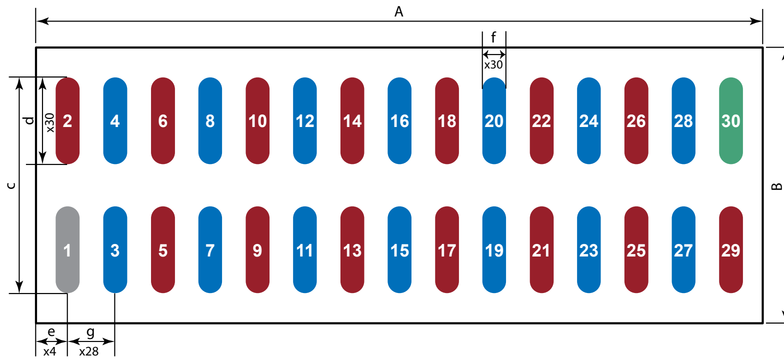
## DIE MARKINGS




| Part Number | Laser Markings: Part # Marking Line 1 | Lot_Date Code Marking Line 2 | Lot_Date Code Marking Line 3 |
|---|---|---|---|
| EPC2206 | 2206 | YYYY | ZZZZ |

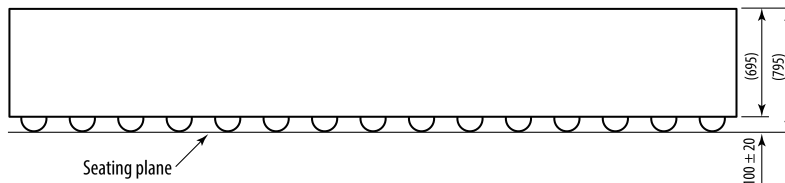
## DIE OUTLINE

Solder Bump View




| DIM | Micrometers MIN | Nominal | MAX |
|---|---|---|---|
| A | 6020 | 6050 | 6080 |
| B | 2270 | 2300 | 2330 |
| c | 2047 | 2050 | 2053 |
| d | 717 | 720 | 723 |
| e | 210 | 225 | 240 |
| f | 195 | 200 | 205 |
| g | 400 | 400 | 400 |

Side View




**Pad 1 is Gate;**

**Pads 2 ,5, 6, 9, 10, 13, 14, 17, 18, 21, 22, 25, 26, 29 are Source;**

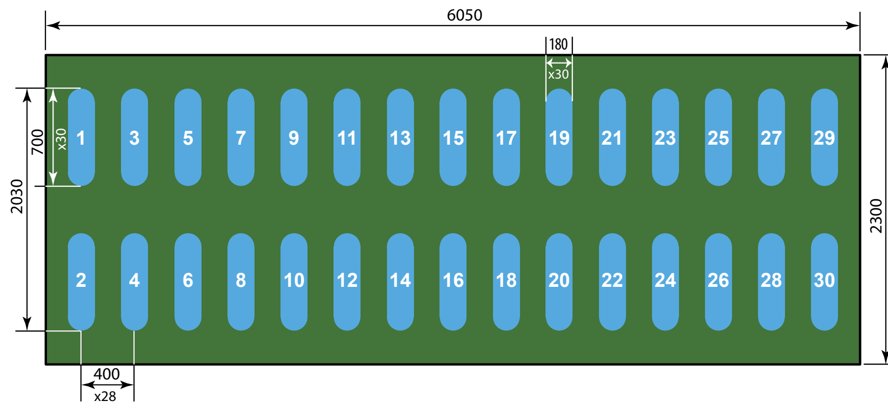
**Pads 3, 4, 7, 8, 11, 12, 15, 16, 19, 20, 23, 24, 27, 28 are Drain;**

**Pad 30 is Substrate.***

*Substrate pin should be connected to Source

## RECOMMENDED LAND PATTERN

*(units in µm)*




Land pattern is solder mask defined.

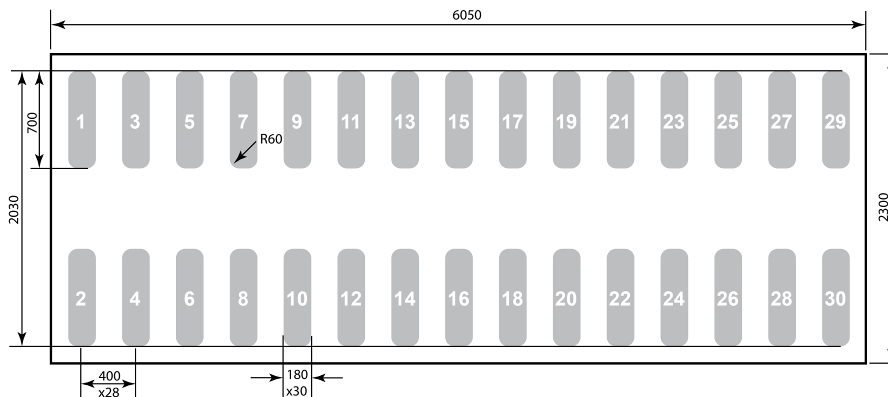
Pad 1 is Gate;
Pads 2, 5, 6, 9,10,13,14, 17, 18, 21, 22, 25, 26, 29 are Source;
Pads 3, 4, 7, 8, 11, 12, 15, 16, 19, 20, 23, 24, 27, 28 are Drain;
Pad 30 is Substrate.*

*Substrate pin should be connected to Source

Solder mask
(for solder mask defined pads)

## RECOMMENDED STENCIL DRAWING

*(units in µm)*




Recommended stencil should be 4 mil (100 µm) thick, must be laser cut, openings per drawing.

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

## TYPICAL THERMAL CONCEPT

The EPC2206 can take advantage of dual sided cooling to maximize its heat dissipation capabilities in high power density designs.

Recommended best practice thermal solutions are covered in detail in **How2AppNote012 - How to Get More Power Out of an eGaN Converter.pdf**.

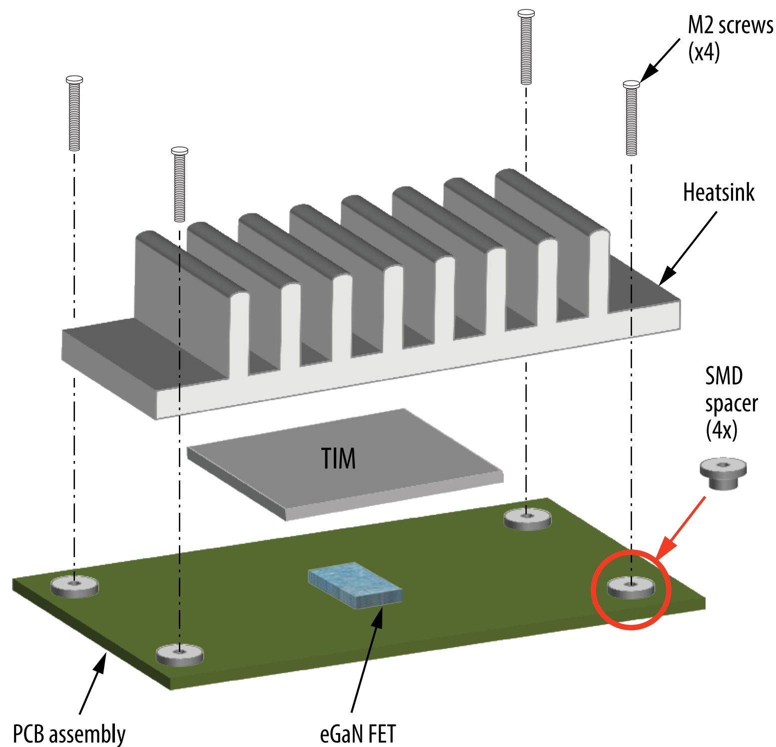



*Figure 13: Exploded view of heatsink assembly using screws*

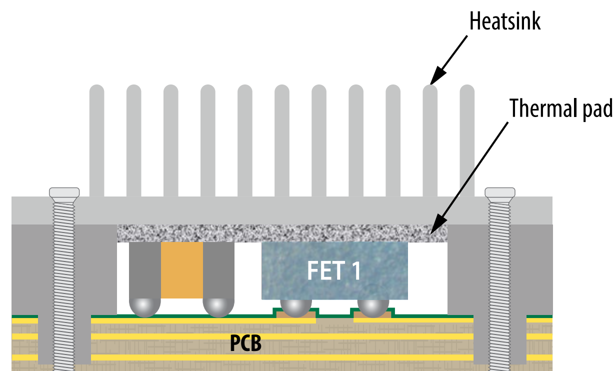



*Figure 14: A cross-section image of dual sided thermal solution*

**Note: Connecting the heatsink to ground is recommended and can significantly improve radiated EMI**

The thermal design can be optimized by using the ***GaN FET Thermal Calculator*** on EPC's website.

Solder mask defined pads are recommended for best reliability.

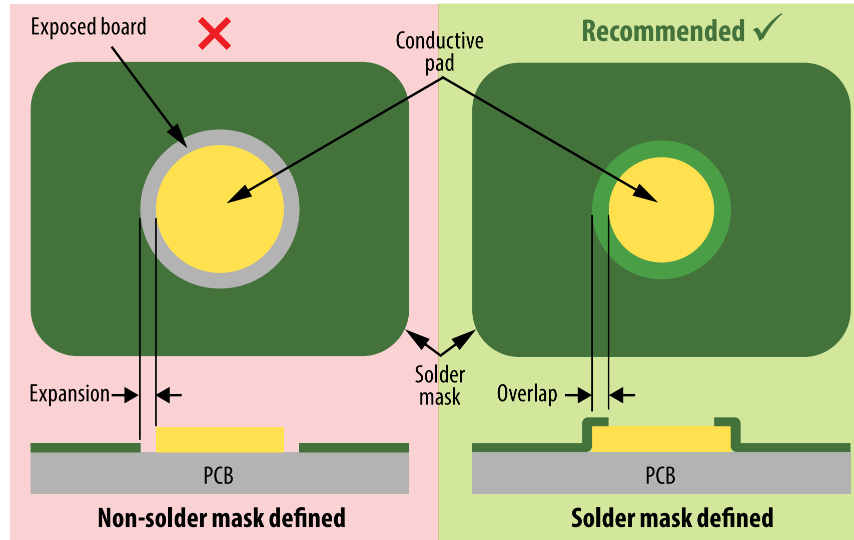



*Figure 15: Solder mask defined versus non-solder mask defined pad*

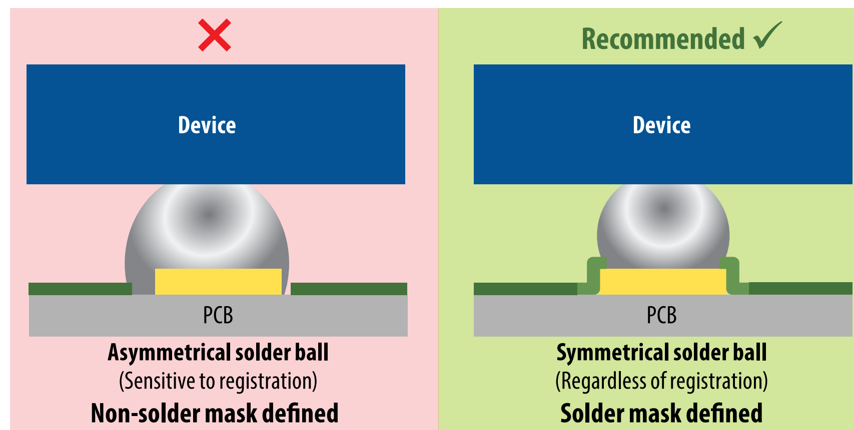



*Figure 16: Effect of solder mask design on the solder ball symmetry*

- Assembly resources – **https://epc-co.com/epc/Portals/0/epc/documents/product-training/Appnote_GaNassembly.pdf**
- Library of Altium footprints for production FETs and ICs – **https://epc-co.com/epc/documents/altium-files/EPC%20Altium%20Library.zip** (for preliminary device Altium footprints, contact EPC)

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